Unit in mm

TENTATIVE

TOSHIBA INFRARED LED GaA&As INFRARED EMITTER

TLN225

INFRARED LED FOR SPACE-OPTICAL-TRANSMISSION

High radiant power: Po=18mW (Typ.) at IF=50mA

Wide radiant pattern : $\theta = \pm 21^{\circ}$ (Typ.)

High speed response : t_r , $t_f = 30$ ns (Typ.)

A light source for remote control.

Wireless AV-signal transmission purpose.

High speed data transmission purpose.

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Forward Current	IF	100	mA
Pulse Forward Current	IFP	1000 (Note 1)	mA
Power Dissipation	$P_{\mathbf{D}}$	220	mW
Reverse Voltage	$V_{\mathbf{R}}$	4	V
Operating temperature Range	$T_{ m opr}$	-25~85	$^{\circ}\mathrm{C}$
Storage Temperature Range	$\mathrm{T_{stg}}$	-30~100	$^{\circ}\mathrm{C}$
Soldering Temperature (5s)	T_{sol}	260	$^{\circ}\mathrm{C}$

(Note:1) Frequency=100kHz, duty=1%

PIN CONNECTION



1.2MAX

(Includes

JEDEC EIAJ

TOSHIBA

0.5 ± 0.1

resin-mold portion) (): REFERENCE VALUE

0.5±0.1

1. ANODE

4-5MA1

2. CATHODE

OPTO-ELECTRICAL CHARA	CTERISTIC	S(Ta = 1)	25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Forward Voltage	$V_{\mathbf{F}}$	I _F =100mA	_	1.6	1.8	V
Reverse Current	I_{R}	$V_R=4V$	_	_	10	μ A
Radiant Power	PO	$I_{ m F}\!=\!50{ m mA}$	14	18	_	mW
Radiant Intensity	$I_{\mathbf{E}}$	$I_{\mathbf{F}} = 50 \text{mA}$	_	40	_	mW/sr
Rise Time, Fall Time	t _r , t _f	I _{FP} =100mA, P _W =100ns	_	30	_	ns
Cut-off Frequency (Note:2)	f_c	$I_{\rm F} = 50 {\rm mA_{DC}} + 5 {\rm mA_{P-P}}$	10	15	_	MHz
Capacitance	$\mathrm{c_{T}}$	$V_R = 0$, $f = 1MHz$	_	110		рF
Peak Emission Wavelength	$\lambda_{\mathbf{P}}$	$I_{\mathbf{F}} = 50 \text{mA}$	830	870	900	nm
Spectral Line Half Width	Δλ	$I_{ m F}\!=\!50{ m mA}$	_	50	_	nm
Half Value Angle	$\theta_{\frac{1}{2}}$	$I_{ m F}\!=\!50{ m mA}$	_	±21	_	٥

- TOSHIBA is continually working to improve the quality and the reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to observe standards of safety, and to avoid situations in which a malfunction or failure of a TOSHIBA product could cause loss of human life, bodily injury or damage to property. In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent products specifications. Also, please keep in mind the precautions and conditions set forth in the TOSHIBA Semiconductor Reliability Handbook.

 Gallium arsenide (GaAs) is a substance used in the products described in this document. GaAs dust and fumes are toxic. Do not break, cut or pulverize the product, or use chemicals to dissolve them. When disposing of the products, follow the appropriate regulations. Do not dispose of the products with other industrial waste or with domestic garbage.

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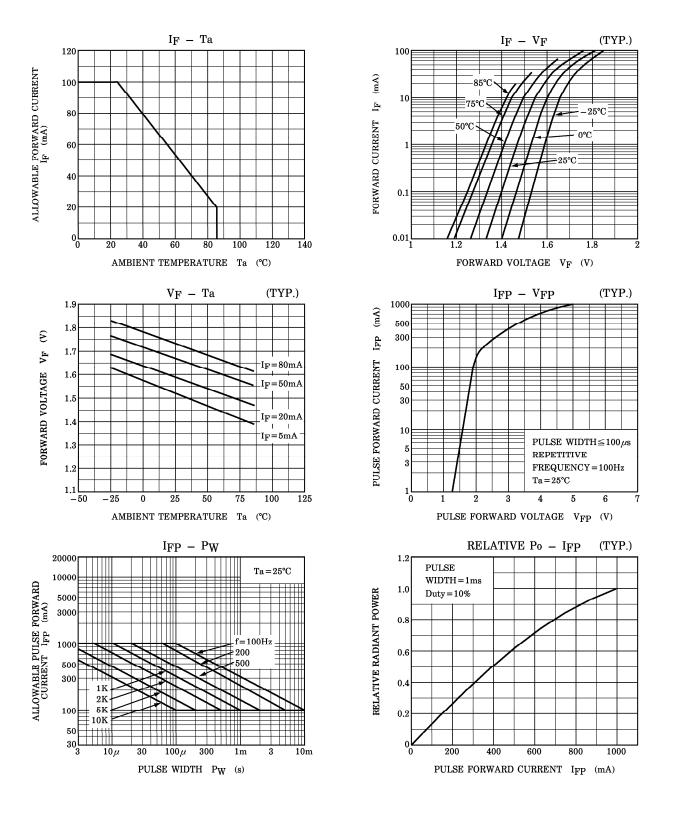
 The information contained herein is subject to change without notice.

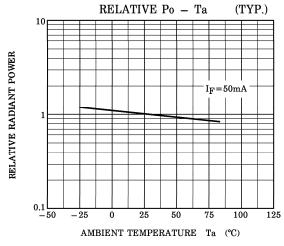
PRECAUTION

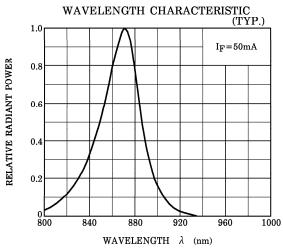
Please be careful of the followings.

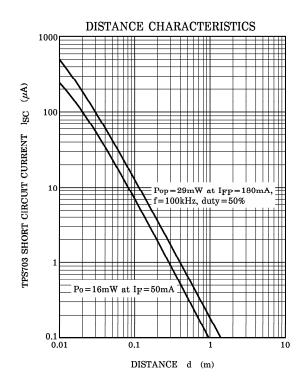
- 1. Soldering shall be performed at the top portion from the lead stopper.
- 2. When the lead is formed, the lead shall be formed at the top portion of the stopper without leaving forming stress to the body of the device.

 Soldering shall be performed after lead forming.









RADIATION PATTERN (TYP.) ${\it Ta} = 25^{\circ}{\it C}$

